Search Notes

Application/Control	No. Applicant Reexamin	(s)/Patent under ation
10/715,376	SUN ET A	AL.
Examiner	Art Unit	
Thinh T. Nguyen	2818	

SEARCHED				
Class	Subclass	Date	Examiner	
257	295	7/30/2005	TTN	
257	30	7/30/2005	TTN	
257	421	7/31/2005	TTN	
257	427	7/31/2005	TTN	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	7/31/2005	TTN		
EAST	7/30/2005	TTN		